

## Freescale Semiconductor

Data Sheet: Technical Data

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# MCF5271 Integrated Microprocessor Hardware Specification

by: Microcontroller Solutions Group

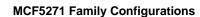
The MCF5271 family is a highly integrated implementation of the ColdFire<sup>®</sup> family of reduced instruction set computing (RISC) microprocessors. This document describes pertinent features and functions of the MCF5271 family. The MCF5271 family includes the MCF5271 and MCF5270 microprocessors. The differences between these parts are summarized below in Table 1. This document is written from the perspective of the MCF5271 and unless otherwise noted, the information applies also to the MCF5270.

The MCF5271 family combines low cost with high integration on the popular version 2 ColdFire core with over 144 (Dhrystone 2.1) MIPS at 150 MHz. Positioned for applications requiring a cost-sensitive 32-bit solution, the MCF5271 family features a 10/100 Ethernet MAC and optional hardware encryption to ensure the application can be connected and protected. In addition, the MCF5271 family features an enhanced multiply accumulate unit (eMAC), large on-chip memory (64 Kbytes SRAM, 8 Kbytes configurable cache), and a 32-bit SDR SDRAM memory controller.

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# **1 MCF5271 Family Configurations**

**Table 1. MCF5271 Family Configurations** 

Module	MCF5270	MCF5271
ColdFire V2 Core with EMAC and Hardware Divide	х	Х
System Clock	150	MHz
Performance (Dhrystone/2.1 MIPS)	14	14
Instruction/Data Cache	8 Kb	oytes
Static RAM (SRAM)	64 K	bytes
Interrupt Controllers (INTC)	2	2
Edge Port Module (EPORT)	х	х
External Interface Module (EIM)	х	х
4-channel Direct-Memory Access (DMA)	х	х
SDRAM Controller	х	х
Fast Ethernet Controller (FEC)	х	х
Hardware Encryption	_	х
Watchdog Timer (WDT)	х	х
Four Periodic Interrupt Timers (PIT)	х	х
32-bit DMA Timers	4	4
QSPI	х	х
UART(s)	3	3
I <sup>2</sup> C	х	х
General Purpose I/O Module (GPIO)	х	х
JTAG - IEEE 1149.1 Test Access Port	х	х
Package	160 QFP, 196 MAPBGA	160 QFP, 196 MAPBGA

# 2 Block Diagram

The superset device in the MCF5271 family comes in a 196 mold array plastic ball grid array (MAPBGA) package. Figure 1 shows a top-level block diagram of the MCF5271.



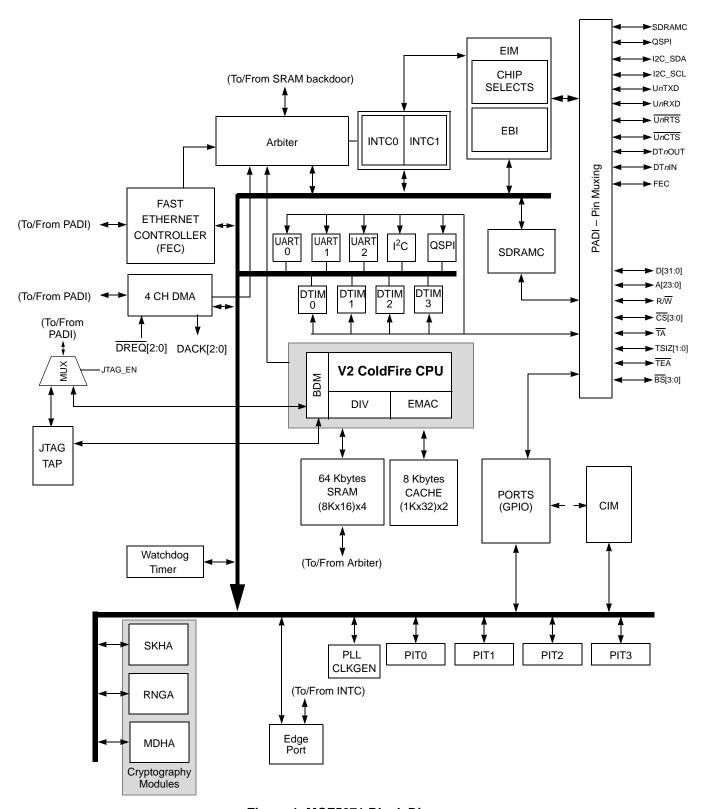


Figure 1. MCF5271 Block Diagram



**Features** 

## 3 Features

For a detailed feature list see the MCF5271 Reference Manual (MCF5271RM).

# 4 Signal Descriptions

This section describes signals that connect off chip, including a table of signal properties. For a more detailed discussion of the MCF5271 signals, consult the *MCF5271 Reference Manual* (MCF5271RM).

# 4.1 Signal Properties

Table 4 lists all of the signals grouped by function. The "Dir" column is the direction for the primary function of the pin. Refer to Section 6, "Mechanicals/Pinouts and Part Numbers," for package diagrams.

#### **NOTE**

In this table and throughout this document a single signal within a group is designated without square brackets (i.e., A24), while designations for multiple signals within a group use brackets (i.e., A[23:21]) and is meant to include all signals within the two bracketed numbers when these numbers are separated by a colon.

#### NOTE

The primary functionality of a pin is not necessarily its default functionality. Pins that are muxed with GPIO will default to their GPIO functionality.

Table 2. MCF5270 and MCF5271 Signal Information and Muxing

Signal Name GPIO Alternate		Alternate 1	Alternate 2 Dir. <sup>1</sup>		MCF5270 MCF5271 160 QFP	MCF5270 MCF5271 196 MAPBGA				
Reset										
RESET   -   -   1   83   N13										
RSTOUT	_	_	_	0	82	P13				
	Clock									
EXTAL	_	_	_	I	86	M14				
XTAL	_	_	_	0	85	N14				
CLKOUT	_	_	_	0	89	K14				
		Мо	ode Selection	n						
CLKMOD[1:0]	_	_	_	I	20,21	G5,H5				
RCON		_	_ I		79	K10				
	External Memory Interface and Ports									
A[23:21]	PADDR[7:5]	CS[6:4]	_	0	126, 125, 124	B11, C11, D11				



Table 2. MCF5270 and MCF5271 Signal Information and Muxing (continued)

Signal Name	GPIO	Alternate 1	Alternate 2	Dir. <sup>1</sup>	MCF5270 MCF5271 160 QFP	MCF5270 MCF5271 196 MAPBGA				
A[20:0]	_	_		0	123:115, 112:106, 102:98	A12, B12, C12, A13, B13, B14, C13, C14, D12, D13, D14, E11, E12, E13, E14, F12, F13, F14, G11, G12, G13				
D[31:16]	1	1	1	0	22:30, 33:39	G1, G2, H1, H2, H3, H4, J1, J2, J3, J4, K1, K2, K3, K4, L1, L2				
D[15:8]	PDATAH[7:0]			0	42:49	M1, N1, M2, N2, P2, L3, M3, N3				
D[7:0]	PDATAL[7:0]	_	_	0	50:52, 56:60	P3, M4, N4, P4, L5, M5, N5, P5				
BS[3:0]	BS[3:0] PBS[7:4]		_	0	143:140	B6, C6, D7, C7				
ŌĒ	OE PBUSCTL7		_	0	62	N6				
TA	PBUSCTL6	_	_	I	96	H11				
TEA	PBUSCTL5	DREQ1	_	I	_	J14				
R/W	PBUSCTL4	_	_	0	95	J13				
TSIZ1	PBUSCTL3	DACK1	_	0	_	P6				
TSIZ0	PBUSCTL2	DACK0	_	0	_	P7				
TS	PBUSCTL1	DACK2	_	0	97	H13				
TIP	PBUSCTL0	DREQ0	_	0	_	H12				
		C	hip Selects							
CS[7:4]	PCS[7:4]	_	_	0	_	B9, A10, C10, A11				
<u>CS</u> [3:2]	PCS[3:2]	SD_CS[1:0]	_	0	132,131	A9, C9				
CS1	PCS1	_		0	130	B10				
CS0		_	_	0	129	D10				
SDRAM Controller										
SD_WE	PSDRAM5	_	_	0	92	K13				
SD_SCAS	PSDRAM4	_	_	0	91	K12				
SD_SRAS	PSDRAM3	_	_	0	90	K11				
SD_CKE	PSDRAM2	_	_	0	_	E8				
SD_CS[1:0]	PSDRAM[1:0]	_	_	0	_	L12, L13				



#### **Signal Descriptions**

Table 2. MCF5270 and MCF5271 Signal Information and Muxing (continued)

Signal Name	GPIO	GPIO Alternate 1 Alternate 2			MCF5270 MCF5271 160 QFP	MCF5270 MCF5271 196 MAPBGA						
External Interrupts Port												
IRQ[7:3]         PIRQ[7:3]         —         I         IRQ7=63 IRQ4=64         N7, N           IRQ2         PIRQ2         DREQ2         —         I         —												
ĪRQ2	PIRQ2	DREQ2	_	I	_	M8						
ĪRQ1	PIRQ1	_	_	I	65	L8						
			FEC									
EMDC	EMDC         PFECI2C3         I2C_SCL         U2TXD         O         151         D4											
EMDIO	PFECI2C2	I2C_SDA	U2RXD	I/O	150	D5						
ECOL	_	_	_	I	9	E2						
ECRS	_	_	_	I	8	E1						
ERXCLK		_	_	I	7	D1						
ERXDV	_	_	_	I	6	D2						
ERXD[3:0]		_	_	Ι	5:2	D3, C1, C2, B1						
ERXER		_	_	0	159	B2						
ETXCLK		_	_	Ι	158	A2						
ETXEN	ETXEN —		_	I	157	C3						
ETXER	_	_	_	0	156	В3						
ETXD[3:0] —		_	_	0	155:152	A3, A4, C4, B4						
			I <sup>2</sup> C									
I2C_SDA	PFECI2C1	_	_	I/O	_	J12						
I2C_SCL	PFECI2C0	_	_	I/O	_	J11						
		l	DMA									
DACK[2:0] and DREQ[2:0] do not have a dedicated bond pads. Please refer to the following pins for muxing:  TS and DT2OUT for DACK2, TSIZ1and DT1OUT for DACK1, TSIZ0 and DT0OUT for DACK0, IRQ2 and DT2IN for DREQ2, TEA and DT1IN for DREQ1, and TIP and DT0IN for DREQ0.												
QSPI												
QSPI_CS1	PQSPI4	SD_CKE	_	0	139	В7						
QSPI_CS0	PQSPI3	_	_	0	146	A6						
QSPI_CLK	PQSPI2	I2C_SCL	_	0	147	C5						
QSPI_DIN	PQSPI1	I2C_SDA	_	Ţ	148	B5						
QSPI_DOUT	PQSPI0	_	_	0	149	A5						



Table 2. MCF5270 and MCF5271 Signal Information and Muxing (continued)

Signal Name GPIO Alt		Alternate 1	Alternate 2	Dir. <sup>1</sup>	MCF5270 MCF5271 160 QFP	MCF5270 MCF5271 196 MAPBGA					
UARTS											
U2TXD	_	A8									
U2RXD	PUARTH0	_	_	I	_	A7					
<u>U1CTS</u>	PUARTL7	U2CTS	_	I	136	B8					
U1RTS	PUARTL6	U2RTS	_	0	135	C8					
U1TXD	PUARTL5	_	_	0	133	D9					
U1RXD	PUARTL4	_	_	I	134	D8					
U0CTS	PUARTL3	_	_	I	12	F3					
U0RTS	PUARTL2	_	_	0	15	G3					
U0TXD	PUARTL1	_	_	0	14	F1					
U0RXD	PUARTL0	_	_	I	13	F2					
			MA Timers			<u> </u>					
DT3IN PTIMER7 U2CTS		U2CTS	QSPI_CS2	I	_	H14					
DT3OUT	PTIMER6	U2RTS	QSPI_CS3	0	_	G14					
DT2IN	PTIMER5	DREQ2	DT2OUT	I	66	M9					
DT2OUT	PTIMER4	DACK2	_	0	_	L9					
DT1IN	PTIMER3	DREQ1	DT1OUT	I	61	L6					
DT1OUT	PTIMER2	DACK1	_	0	_	M6					
DT0IN	PTIMER1	DREQ0	_	I	10	E4					
DT0OUT	PTIMER0	DACK0	_	0	11	F4					
		E	BDM/JTAG <sup>2</sup>			•					
DSCLK	_	TRST	_	0	70	N9					
PSTCLK	_	TCLK	_	0	68	P9					
BKPT	_	TMS	_	0	71	P10					
DSI	_	TDI	_	I	73	M10					
DSO	_	TDO	_	0	72	N10					
JTAG_EN	_	_	_	I	78	K9					
DDATA[3:0]	_	_	_	0	_	M12, N12, P12, L11					
PST[3:0]	_	_	_	0	77:74	M11, N11, P11, L10					



#### **Design Recommendations**

Table 2. MCF5270 and MCF5271 Signal Information and Muxing (continued)

Signal Name	GPIO	GPIO Alternate 1 Alternate 2		Dir. <sup>1</sup>	MCF5270 MCF5271 160 QFP	MCF5270 MCF5271 196 MAPBGA				
Test										
TEST	_	_	_	I	19	F5				
PLL_TEST	_	_	_	I	_					
		Ро	wer Supplie	s						
VDDPLL	_	_	_	I	87	M13				
VSSPLL			_	I	84	L14				
OVDD			_	I	1, 18, 32, 41, 55, 69, 81, 94, 105, 114, 128, 138, 145					
VSS	_	_	_	I	17, 31, 40, 54, 67, 80, 88, 93, 104, 113, 127, 137, 144, 160	A1, A14, E6, E9, F6, F8, F10, G7, G9, H6, J5, J7, J9, K7, P1, P14				
VDD	_	_	_	I	16, 53, 103	D6, F11, G4, L4				

Refers to pin's primary function. All pins which are configurable for GPIO have a pullup enabled in GPIO mode with the exception of PBUSCTL[7], PBUSCTL[4:0], PADDR, PBS, PSDRAM.

# 5 Design Recommendations

# 5.1 Layout

- Use a 4-layer printed circuit board with the VDD and GND pins connected directly to the power and ground planes for the MCF5271.
- See application note AN1259, System Design and Layout Techniques for Noise Reduction in Processor-Based Systems.
- Match the PC layout trace width and routing to match trace length to operating frequency and board impedance. Add termination (series or therein) to the traces to dampen reflections. Increase the PCB impedance (if possible) keeping the trace lengths balanced and short. Then do cross-talk analysis to separate traces with significant parallelism or are otherwise "noisy". Use 6 mils trace and separation. Clocks get extra separation and more precise balancing.

# 5.2 Power Supply

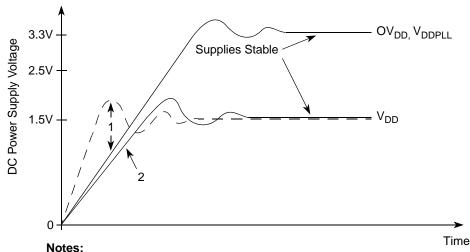
• 33  $\mu$ F, 0.1  $\mu$ F, and 0.01  $\mu$ F across each power supply

If JTAG\_EN is asserted, these pins default to Alternate 1 (JTAG) functionality. The GPIO module is not responsible for assigning these pins.



## 5.2.1 Supply Voltage Sequencing and Separation Cautions

Figure 2 shows situations in sequencing the I/O  $V_{DD}$  (OV $_{DD}$ ), PLL  $V_{DD}$  (V $_{DDPLL}$ ), and Core  $V_{DD}$  (V $_{DD}$ ). OV $_{DD}$  is specified relative to  $V_{DD}$ .



- VDD should not exceed OVDD or VDDPLL by more than 0.4 V at any time, including power-up.
  - Recommended that VDD should track OVDD/VDDPLL up to 0.9 V, then separate for completion of ramps.
- 3. Input voltage must not be greater than the supply voltage (OVDD, VDD, or VDDPLL) by more than 0.5 V at any time, including during power-up.
- 4. Use 1 ms or slower rise time for all supplies.

Figure 2. Supply Voltage Sequencing and Separation Cautions

## 5.2.1.1 Power Up Sequence

If  $OV_{DD}$  is powered up with  $V_{DD}$  at 0 V, then the sense circuits in the I/O pads cause all pad output drivers connected to the  $OV_{DD}$  to be in a high impedance state. There is no limit on how long after  $OV_{DD}$  powers up before  $V_{DD}$  must power up.  $V_{DD}$  should not lead the  $OV_{DD}$  or  $V_{DDPLL}$  by more than 0.4 V during power ramp-up, or there will be high current in the internal ESD protection diodes. The rise times on the power supplies should be slower than 1  $\mu$ s to avoid turning on the internal ESD protection clamp diodes.

The recommended power up sequence is as follows:

- 1. Use 1 ms or slower rise time for all supplies.
- 2.  $V_{DD}$  and  $OV_{DD}/V_{DDPLL}$  should track up to 0.9 V, then separate for the completion of ramps with  $OV_{DD}$  going to the higher external voltages. One way to accomplish this is to use a low drop-out voltage regulator.

## 5.2.1.2 Power Down Sequence

If  $V_{DD}$  is powered down first, then sense circuits in the I/O pads cause all output drivers to be in a high impedance state. There is no limit on how long after  $V_{DD}$  powers down before  $OV_{DD}/V_{DDPLL}$  must power down.  $V_{DD}$  should not lag  $OV_{DD}$  or  $V_{DDPLL}$  going low by more than 0.4 V during power down or there



#### **Design Recommendations**

will be undesired high current in the ESD protection diodes. There are no requirements for the fall times of the power supplies.

The recommended power down sequence is as follows:

- 1. Drop V<sub>DD</sub> to 0 V.
- 2. Drop OV<sub>DD</sub>/V<sub>DDPLL</sub> supplies.

# 5.3 Decoupling

- Place the decoupling caps as close to the pins as possible, but they can be outside the footprint of the package.
- 0.1 μF and 0.01 μF at each supply input

## 5.4 Buffering

• Use bus buffers on all data/address lines for all off-board accesses and for all on-board accesses when excessive loading is expected. See Section 7, "Electrical Characteristics."

## 5.5 Pull-up Recommendations

• Use external pull-up resistors on unused inputs. See pin table.

## 5.6 Clocking Recommendations

- Use a multi-layer board with a separate ground plane.
- Place the crystal and all other associated components as close to the EXTAL and XTAL (oscillator pins) as possible.
- Do not run a high frequency trace around crystal circuit.
- Ensure that the ground for the bypass capacitors is connected to a solid ground trace.
- Tie the ground trace to the ground pin nearest EXTAL and XTAL. This prevents large loop currents in the vicinity of the crystal.
- Tie the ground pin to the most solid ground in the system.
- Do not connect the trace that connects the oscillator and the ground plane to any other circuit element. This tends to make the oscillator unstable.
- Tie XTAL to ground when an external oscillator is clocking the device.

## 5.7 Interface Recommendations

#### 5.7.1 SDRAM Controller

## 5.7.1.1 SDRAM Controller Signals in Synchronous Mode

Table 3 shows the behavior of SDRAM signals in synchronous mode.



**Table 3. Synchronous DRAM Signal Connections** 

Signal	Description
SD_SRAS	Synchronous row address strobe. Indicates a valid SDRAM row address is present and can be latched by the SDRAM. $\overline{SD\_SRAS}$ should be connected to the corresponding SDRAM $\overline{SD\_SRAS}$ . Do not confuse $\overline{SD\_SRAS}$ with the DRAM controller's $\overline{SD\_CS}$ [1:0], which should not be interfaced to the SDRAM $\overline{SD\_SRAS}$ signals.
SD_SCAS	Synchronous column address strobe. Indicates a valid column address is present and can be latched by the SDRAM. SD_SCAS should be connected to the corresponding signal labeled SD_SCAS on the SDRAM.
DRAMW	DRAM read/write. Asserted for write operations and negated for read operations.
SD_CS[1:0]	Row address strobe. Select each memory block of SDRAMs connected to the MCF5271. One SD_CS signal selects one SDRAM block and connects to the corresponding CS signals.
SD_CKE	Synchronous DRAM clock enable. Connected directly to the CKE (clock enable) signal of SDRAMs. Enables and disables the clock internal to SDRAM. When CKE is low, memory can enter a power-down mode where operations are suspended or they can enter self-refresh mode. SD_CKE functionality is controlled by DCR[COC]. For designs using external multiplexing, setting COC allows SD_CKE to provide command-bit functionality.
BS[3:0]	Column address strobe. For synchronous operation, $\overline{BS}[3:0]$ function as byte enables to the SDRAMs. They connect to the DQM signals (or mask qualifiers) of the SDRAMs.
CLKOUT	Bus clock output. Connects to the CLK input of SDRAMs.

## 5.7.1.2 Address Multiplexing

See the SDRAM controller module chapter in the *MCF5271 Reference Manual* for details on address multiplexing.

## 5.7.2 Ethernet PHY Transceiver Connection

The FEC supports both an MII interface for 10/100 Mbps Ethernet and a seven-wire serial interface for 10 Mbps Ethernet. The interface mode is selected by R\_CNTRL[MII\_MODE]. In MII mode, the 802.3 standard defines and the FEC module supports 18 signals. These are shown in Table 4.

Table 4. MII Mode

Signal Description	MCF5271 Pin
Transmit clock	ETXCLK
Transmit enable	ETXEN
Transmit data	ETXD[3:0]
Transmit error	ETXER
Collision	ECOL
Carrier sense	ECRS
Receive clock	ERXCLK
Receive enable	ERXDV
Receive data	ERXD[3:0]

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#### **Mechanicals/Pinouts and Part Numbers**

**Table 4. MII Mode (continued)** 

Signal Description	MCF5271 Pin
Receive error	ERXER
Management channel clock	EMDC
Management channel serial data	EMDIO

The serial mode interface operates in what is generally referred to as AMD mode. The MCF5271 configuration for seven-wire serial mode connections to the external transceiver are shown in Table 5.

**Table 5. Seven-Wire Mode Configuration** 

Signal Description	MCF5271 Pin
Transmit clock	ETXCLK
Transmit enable	ETXEN
Transmit data	ETXD[0]
Collision	ECOL
Receive clock	ERXCLK
Receive enable	ERXDV
Receive data	ERXD[0]
Unused, configure as PB14	ERXER
Unused input, tie to ground	ECRS
Unused, configure as PB[13:11]	ERXD[3:1]
Unused output, ignore	ETXER
Unused, configure as PB[10:8]	ETXD[3:1]
Unused, configure as PB15	EMDC
Input after reset, connect to ground	EMDIO

Refer to the M5271EVB evaluation board user's manual for an example of how to connect an external PHY. Schematics for this board are accessible at the MCF5271 site by navigating to: <a href="http://www.freescale.com/coldfire">http://www.freescale.com/coldfire</a>.

#### 5.7.3 BDM

Use the BDM interface as shown in the M5271EVB evaluation board user's manual. The schematics for this board are accessible at the Freescale website at: http://www.freescale.com/coldfire.

# 6 Mechanicals/Pinouts and Part Numbers

This section contains drawings showing the pinout and the packaging and mechanical characteristics of the MCF5271 devices. See Table 4 for a list the signal names and pin locations for each device.



# 6.1 Pinout—196 MAPBGA

The following figure shows a pinout of the MCF5270/71CVMxxx package.

	1	2	3	4	5	6	7	8	9	10	11	12	13	14	_
Α		ETXCLK	ETXD3	ETXD2	QSPI_ DOUT	QSPI_CS0	U2RXD	U2TXD	CS3	CS6	CS4	A20	A17		А
В	ERXD0	ERXER	ETXER	ETXD0	QSPI_DIN	BS3	QSPI_CS1	U1CTS	CS7	CS1	A23	A19	A16	A15	В
С	ERXD2	ERXD1	ETXEN	ETXD1	QSCK	BS2	BS0	RTS1	CS2	CS5	A22	A18	A14	A13	С
D	ERXCLK	ERXDV	ERXD3	EMDC	EMDIO	Core VDD_4	BS1	U1RXD1	U1TXD	CS0	A21	A12	A11	A10	D
Е	ECRS	ECOL	NC	TIN0	VDD	VSS	VDD	SD_CKE	VSS	VDD	А9	A8	A7	A6	Е
F	U0TXD	U0RXD	U0CTS	DTOUT0	TEST		VDD	VSS	VDD	VSS	Core VDD_3	A5	A4	A3	F
G	D31	D30	U0RTS	Core VDD_1	CLK MOD1	VDD	VSS	VDD	VSS	NC	A2	A1	A0	DTOUT3	G
Н	D29	D28	D27	D26	CLK MOD0	VSS	VDD	VDD	VDD	NC	TA	TIP	TS	DTIN3	Н
J	D25	D24	D23	D22	VSS	VDD	VSS	VDD	VSS	VDD	I2C_SCL	I2C_SDA	R/W	TEA	J
K	D21	D20	D19	D18	VDD	VDD		VDD	JTAG_EN	RCON	SD_ RAS	SD_ CAS	SD_WE	CLKOUT	К
L	D17	D16	D10	Core VDD_2	D3	DTIN1	ĪRQ5	ĪRQ1	DTOUT2	PST0	DDATA0	SD_CS1	SD_CS0	VSSPLL	L
М	D15	D13	D9	D6	D2	DTOUT1	ĪRQ6	ĪRQ2	DTIN2	TDI/DSI	PST3	DDATA3	VDDPLL	EXTAL	М
Ν	D14	D12	D8	D5	D1	ŌĒ	ĪRQ7	ĪRQ3	TRST/ DSCLK	TDO/DSO	PST2	DDATA2	RESET	XTAL	N
Р	VSS	D11	D7	D4	D0	TSIZ1	TSIZ0	ĪRQ4	TCLK/ PSTCLK	TMS/ BKPT	PST1	DDATA1	RSTOUT	VSS	Р
ļ	1	2	3	4	5	6	7	8	9	10	11	12	13	14	

Figure 3. MCF5270/71CVMxxx Pinout (196 MAPBGA)



**Mechanicals/Pinouts and Part Numbers** 

# 6.2 Package Dimensions—196 MAPBGA

Figure 4 shows MCF5270/71CVMxxx package dimensions.

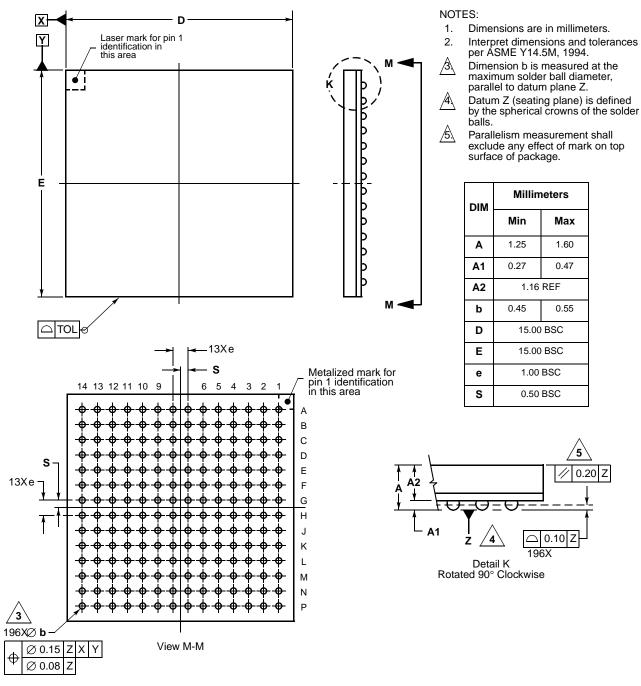


Figure 4. 196 MAPBGA Package Dimensions (Case No. 1128A-01)



## 6.3 Pinout—160 QFP

Figure 5 shows a pinout of the MCF5271CABxxx package.

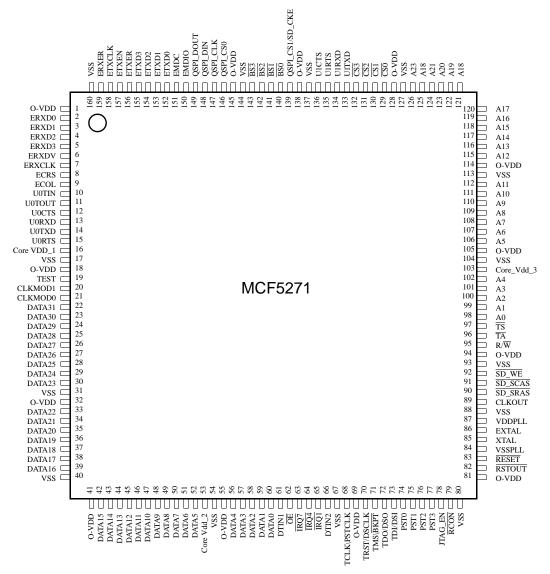


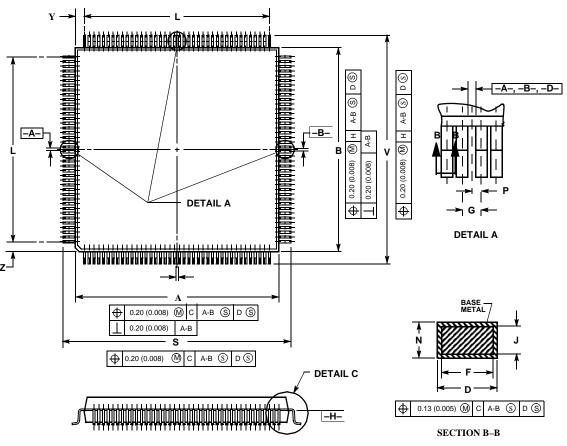
Figure 5. MCF5270/71CABxxx Pinout (160 QFP)

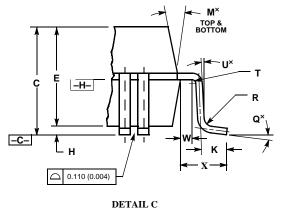


**Mechanicals/Pinouts and Part Numbers** 

# 6.4 Package Dimensions—160 QFP

Figure 6 shows MCF5270/71CAB80 package dimensions.





#### NOTES

- DIMENSIONING AND TOLERINCING PER ANSI
  Y14.5M, 1982.
- 2. CONTROLLING DIMENSION: MILLIMETER
- DATUM PLAN -H- IS LOCATED AT BOTTOM OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE BOTTOM OF THE PARTING LINE.
- 4. DATUMS -A-, -B-, AND -D- TO BE DETERMINED AT DATUM PLANE -H-.
- DIMENSIONS S AND V TO BE DETERMINED AT SEATING PLANE -C-.
- DIMENSIONS A AND B DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS 0.25 (0.010) PER SIDE. DIMENSIONS A AND B DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE -H-.
- 7. DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION. SHALL BE 0.08 (0.003) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION. DAMBAR CANNOT BE LOCATED ON THE LOWER RADIUS OR THE FOOT.

	MILLIM	ETERS	INC	IES	
DIM	MIN	MAX	MIN	MAX	
Α	27.90	28.10	1.098	1.106	
В	27.90	28.10	1.098	1.106	
С	3.35	3.85	0.132	1.106	
D	0.22	0.38	0.009	0.015	
Е	3.20	3.50	0.126	0.138	
F	0.22	0.33	0.009	0.013	
G	0.65 E	3SC	0.026	REF	
Н	0.25	0.35	0.010	0.014	
J	0.11	0.23	0.004	0.009	
K	0.70	0.90	0.028	0.035	
L	25.35	BSC	0.998	REF	
M	5°	16°	5	16°	
N	0.11	0.19	0.004	0.007	
Р	0.325	BSC	0.013	REF	
Q	0°	7°	°°	7°	
R	0.13	0.30	0.005	0.012	
S	31.00	31.40	1.220	1.236	
Т	0.13	_	0.005	-	
U	0°	_	°°	-	
٧	31.00	31.40	1.220	1.236	
W	0.4	_	0.016	ı	
Х	1.60 F	REF	0.063 REF		
Υ		REF	0.052		
Z	1.33 F	REF	0.052	REF	

Case 864A-03

Figure 6. 160 QFP Package Dimensions



#### **Ordering Information** 6.5

**Table 6. Orderable Part Numbers** 

Freescale Part Number	Description	Package	Speed	Lead-Free?	Temperature
MCF5270AB100	MCF5270 RISC Microprocessor	160 QFP	100MHz	Yes	0° to +70° C
MCF5270CAB100	MCF5270 RISC Microprocessor	160 QFP	100MHz	Yes	-40° to +85° C
MCF5270VM100	MCF5270 RISC Microprocessor	196 MAPBGA	100MHz	Yes	0° to +70° C
MCF5270CVM150	MCF5270 RISC Microprocessor	196 MAPBGA	150MHz	Yes	-40° to +85° C
MCF5271CAB100	MCF5271 RISC Microprocessor	160 QFP	100MHz	Yes	-40° to +85° C
MCF5271CVM100	MCF5271 RISC Microprocessor	196 MAPBGA	100MHz	Yes	-40° to +85° C
MCF5271CVM150	MCF5271 RISC Microprocessor	196 MAPBGA	150MHz	Yes	-40° to +85° C

#### **Electrical Characteristics** 7

This chapter contains electrical specification tables and reference timing diagrams for the MCF5271 microcontroller unit. This section contains detailed information on power considerations, DC/AC electrical characteristics, and AC timing specifications of MCF5271.

The parameters specified in this processor document supersede any values found in the module specifications.

#### 7.1 **Maximum Ratings**

Table 7. Absolute Maximum Ratings<sup>1, 2</sup>

Rating	Symbol	Value	Unit
Core Supply Voltage	$V_{DD}$	- 0.5 to +2.0	V
Pad Supply Voltage	$OV_DD$	- 0.3 to +4.0	V
PLL Supply Voltage	V <sub>DDPLL</sub>	- 0.3 to +4.0	V
Digital Input Voltage <sup>3</sup>	V <sub>IN</sub>	- 0.3 to + 4.0	V
Instantaneous Maximum Current Single pin limit (applies to all pins) 3,4,5	I <sub>D</sub>	25	mA
Operating Temperature Range (Packaged)	T <sub>A</sub> (T <sub>L</sub> - T <sub>H</sub> )	- 40 to 85	°C
Storage Temperature Range	T <sub>stg</sub>	- 65 to 150	°C

Functional operating conditions are given in DC Electrical Specifications. Absolute Maximum Ratings are stress ratings only, and functional operation at the maxima is not guaranteed. Continued operation at these levels may affect device reliability or cause permanent damage to the device.



- This device contains circuitry protecting against damage due to high static voltage or electrical fields; however, it is advised that normal precautions be taken to avoid application of any voltages higher than maximum-rated voltages to this high-impedance circuit. Reliability of operation is enhanced if unused inputs are tied to an appropriate logic voltage level (e.g., either V<sub>SS</sub> or OV<sub>DD</sub>).
- Input must be current limited to the value specified. To determine the value of the required current-limiting resistor, calculate resistance values for positive and negative clamp voltages, then use the larger of the two values.
- <sup>4</sup> All functional non-supply pins are internally clamped to V<sub>SS</sub> and OV<sub>DD</sub>.
- Power supply must maintain regulation within operating OV<sub>DD</sub> range during instantaneous and operating maximum current conditions. If positive injection current (V<sub>in</sub> > OV<sub>DD</sub>) is greater than I<sub>DD</sub>, the injection current may flow out of OV<sub>DD</sub> and could result in external power supply going out of regulation. Insure external OV<sub>DD</sub> load will shunt current greater than maximum injection current. This will be the greatest risk when the processor is not consuming power (ex; no clock). Power supply must maintain regulation within operating OV<sub>DD</sub> range during instantaneous and operating maximum current conditions.

### 7.2 Thermal Characteristics

The below table lists thermal resistance values.

**Table 8. Thermal Characteristics** 

Characteristic		Symbol	196 MAPBGA	160QFP	Unit
Junction to ambient, natural convection	Four layer board (2s2p)	$\theta_{JMA}$	32 <sup>1,2</sup>	40 <sup>1,2</sup>	°C/W
Junction to ambient (@200 ft/min)	Four layer board (2s2p)	$\theta_{JMA}$	29 <sup>1,2</sup>	36 <sup>1,2</sup>	°C/W
Junction to board		$\theta_{JB}$	20 <sup>3</sup>	25 <sup>3</sup>	°C/W
Junction to case		$\theta_{\sf JC}$	10 <sup>4</sup>	10 <sup>4</sup>	°C/W
Junction to top of package		$\Psi_{jt}$	2 <sup>1,5</sup>	2 <sup>1,5</sup>	°C/W
Maximum operating junction temperature		T <sub>j</sub>	104	105	°C

 $<sup>\</sup>theta_{JMA}$  and  $\Psi_{jt}$  parameters are simulated in conformance with EIA/JESD Standard 51-2 for natural convection. Motorola recommends the use of  $\theta_{JmA}$  and power dissipation specifications in the system design to prevent device junction temperatures from exceeding the rated specification. System designers should be aware that device junction temperatures can be significantly influenced by board layout and surrounding devices. Conformance to the device junction temperature specification can be verified by physical measurement in the customer's system using the  $\Psi_{jt}$  parameter, the device power dissipation, and the method described in EIA/JESD Standard 51-2.

- Per JEDEC JESD51-6 with the board horizontal.
- Thermal resistance between the die and the printed circuit board in conformance with JEDEC JESD51-8. Board temperature is measured on the top surface of the board near the package.
- Thermal resistance between the die and the case top surface as measured by the cold plate method (MIL SPEC-883 Method 1012.1).
- Thermal characterization parameter indicating the temperature difference between package top and the junction temperature per JEDEC JESD51-2. When Greek letters are not available, the thermal characterization parameter is written in conformance with Psi-JT.

The average chip-junction temperature (T<sub>I</sub>) in °C can be obtained from:

$$\Gamma_{\rm J} = \Gamma_{\rm A} + (P_{\rm D} \times \Theta_{\rm JMA})$$
 (1)

Where:



T<sub>A</sub>= Ambient Temperature, °C

Θ<sub>JMA</sub>= Package Thermal Resistance, Junction-to-Ambient, °C/W

$$P_D = P_{INT} + P_{I/O}$$

 $P_{INT} = I_{DD} \times V_{DD}$ , Watts - Chip Internal Power

P<sub>I/O</sub>= Power Dissipation on Input and Output Pins — User Determined

For most applications  $P_{I/O} < P_{INT}$  and can be ignored. An approximate relationship between  $P_D$  and  $T_J$  (if  $P_{I/O}$  is neglected) is:

$$P_D = K \div (T_J + 273^{\circ}C)$$
 (2)

Solving equations 1 and 2 for K gives:

$$K = P_D \times (T_A + 273 \, ^{\circ}C) + \Theta_{JMA} \times P_D^2$$
 (3)

where K is a constant pertaining to the particular part. K can be determined from equation (3) by measuring  $P_D$  (at equilibrium) for a known  $T_A$ . Using this value of K, the values of  $P_D$  and  $P_D$  can be obtained by solving equations (1) and (2) iteratively for any value of  $P_D$ .

# 7.3 DC Electrical Specifications

Table 9. DC Electrical Specifications<sup>1</sup>

Characteristic	Symbol	Min	Typical	Max	Unit
Core Supply Voltage	V <sub>DD</sub>	1.4	_	1.6	V
Pad Supply Voltage	$OV_{DD}$	3.0	_	3.6	V
PLL Supply Voltage	$V_{DDPLL}$	3.0	_	3.6	V
Input High Voltage	V <sub>IH</sub>	$0.7 \times \text{OV}_{\text{DD}}$	_	3.65	V
Input Low Voltage	V <sub>IL</sub>	V <sub>SS</sub> - 0.3	_	$0.35 \times \text{OV}_{\text{DD}}$	V
Input Hysteresis	V <sub>HYS</sub>	$0.06 \times \text{OV}_{\text{DD}}$	_	_	mV
Input Leakage Current $V_{in} = V_{DD}$ or $V_{SS}$ , Input-only pins	I <sub>in</sub>	-1.0	_	1.0	μΑ
High Impedance (Off-State) Leakage Current $V_{in} = V_{DD}$ or $V_{SS}$ , All input/output and output pins	I <sub>OZ</sub>	-1.0	_	1.0	μΑ
Output High Voltage (All input/output and all output pins) I <sub>OH</sub> = -5.0 mA	V <sub>OH</sub>	OV <sub>DD</sub> - 0.5	_	_	V
Output Low Voltage (All input/output and all output pins) I <sub>OL</sub> = 5.0mA	V <sub>OL</sub>	_	_	0.5	V
Weak Internal Pull Up Device Current, tested at V <sub>IL</sub> Max. <sup>2</sup>	I <sub>APU</sub>	-10	_	- 130	μΑ
Input Capacitance <sup>3</sup> All input-only pins All input/output (three-state) pins	C <sub>in</sub>		_	7 7	pF



Table 9. DC Electrical Specifications<sup>1</sup> (continued)

Characteristic	Symbol	Min	Typical	Max	Unit
Load Capacitance <sup>4</sup> Low drive strength High drive strength	C <sub>L</sub>			25 50	pF pF
Core Operating Supply Current <sup>5</sup> Master Mode	I <sub>DD</sub>	_	135	150	mA
Pad Operating Supply Current Master Mode Low Power Modes	Ol <sub>DD</sub>		100 TBD		mA μA
DC Injection Current <sup>3, 6, 7, 8</sup> V <sub>NEGCLAMP</sub> = V <sub>SS</sub> – 0.3 V, V <sub>POSCLAMP</sub> = V <sub>DD</sub> + 0.3  Single Pin Limit  Total processor Limit, Includes sum of all stressed pins	I <sub>IC</sub>	-1.0 -10		1.0 10	mA mA

Refer to Table 10 for additional PLL specifications.

 $^{6}$  All functional non-supply pins are internally clamped to  $V_{SS}$  and their respective  $V_{DD}$ .

<sup>7</sup> Input must be current limited to the value specified. To determine the value of the required current-limiting resistor, calculate resistance values for positive and negative clamp voltages, then use the larger of the two values.

Power supply must maintain regulation within operating V<sub>DD</sub> range during instantaneous and operating maximum current conditions. If positive injection current (V<sub>in</sub> > V<sub>DD</sub>) is greater than I<sub>DD</sub>, the injection current may flow out of V<sub>DD</sub> and could result in external power supply going out of regulation. Insure external V<sub>DD</sub> load will shunt current greater than maximum injection current. This will be the greatest risk when the processor is not consuming power. Examples are: if no system clock is present, or if clock rate is very low which would reduce overall power consumption. Also, at power-up, system clock is not present during the power-up sequence until the PLL has attained lock.

## 7.4 Oscillator and PLLMRFM Electrical Characteristics

Table 10. HiP7 PLLMRFM Electrical Specifications<sup>1</sup>

Num	Characteristic	Symbol	Min. Value	Max. Value	Unit
1	PLL Reference Frequency Range Crystal reference External reference 1:1 mode (NOTE: f <sub>sys/2</sub> = 2 × f <sub>ref_1:1</sub> )	f <sub>ref_crystal</sub> f <sub>ref_ext</sub> f <sub>ref_1:1</sub>	8 8 24	25 25 75	MHz
2	Core frequency CLKOUT Frequency <sup>2</sup> External reference On-Chip PLL Frequency	f <sub>sys</sub>	0 f <sub>ref</sub> ÷ 32	150 75 75	MHz MHz MHz
3	Loss of Reference Frequency 3, 5	f <sub>LOR</sub>	100	1000	kHz
4	Self Clocked Mode Frequency <sup>4, 5</sup>	f <sub>SCM</sub>	10.25	15.25	MHz
5	Crystal Start-up Time <sup>5, 6</sup>	t <sub>cst</sub>	_	10	ms

Refer to the MCF5271 signals section for pins having weak internal pull-up devices.

<sup>&</sup>lt;sup>3</sup> This parameter is characterized before qualification rather than 100% tested.

<sup>&</sup>lt;sup>4</sup> pF load ratings are based on DC loading and are provided as an indication of driver strength. High speed interfaces require transmission line analysis to determine proper drive strength and termination. See <u>High Speed Signal Propagation:</u> <u>Advanced Black Magic</u> by Howard W. Johnson for design guidelines.

<sup>5</sup> Current measured at maximum system clock frequency, all modules active, and default drive strength with matching load.



## Table 10. HiP7 PLLMRFM Electrical Specifications<sup>1</sup> (continued)

Num	Characteristic	Symbol	Min. Value	Max. Value	Unit
6	XTAL Load Capacitance <sup>5</sup>		5	30	pF
7	PLL Lock Time <sup>5, 7,13</sup>	t <sub>lpll</sub>	_	750	μS
8	Power-up To Lock Time <sup>5, 6,8</sup> With Crystal Reference (includes 5 time) Without Crystal Reference <sup>9</sup>	t <sub>lplk</sub>		11 750	ms μs
9	1:1 Mode Clock Skew (between CLKOUT and EXTAL) <sup>10</sup>	t <sub>skew</sub>	-1	1	ns
10	Duty Cycle of reference <sup>5</sup>	t <sub>dc</sub>	40	60	%
11	Frequency un-LOCK Range	f <sub>UL</sub>	-3.8	4.1	% f <sub>sys/2</sub>
12	Frequency LOCK Range	f <sub>LCK</sub>	-1.7	2.0	% f <sub>sys/2</sub>
13	CLKOUT Period Jitter, <sup>5, 6, 8,11, 12</sup> Measured at f <sub>sys/2</sub> Max Peak-to-peak Jitter (Clock edge to clock edge) Long Term Jitter (Averaged over 2 ms interval)	C <sub>jitter</sub>	_	5.0 .01	% f <sub>sys/2</sub>
14	Frequency Modulation Range Limit <sup>13,14</sup> (f <sub>sys/2</sub> Max must not be exceeded)	C <sub>mod</sub>	0.8	2.2	%f <sub>sys/2</sub>
15	ICO Frequency. $f_{ico} = f_{ref} \times 2 \times (MFD+2)^{-15}$	f <sub>ico</sub>	48	150	MHz

- All values given are initial design targets and subject to change.
- All internal registers retain data at 0 Hz.
- "Loss of Reference Frequency" is the reference frequency detected internally, which transitions the PLL into self clocked mode.
- Self clocked mode frequency is the frequency that the PLL operates at when the reference frequency falls below f<sub>LOR</sub> with default MFD/RFD settings.
- <sup>5</sup> This parameter is guaranteed by characterization before qualification rather than 100% tested.
- <sup>6</sup> Proper PC board layout procedures must be followed to achieve specifications.
- This specification applies to the period required for the PLL to relock after changing the MFD frequency control bits in the synthesizer control register (SYNCR).
- Assuming a reference is available at power up, lock time is measured from the time  $V_{DD}$  and  $V_{DDSYN}$  are valid to RSTOUT negating. If the crystal oscillator is being used as the reference for the PLL, then the crystal start up time must be added to the PLL lock time to determine the total start-up time.
- $t_{|p||} = (64 * 4 * 5 + 5 \tau)$   $T_{ref}$ , where  $T_{ref} = 1/F_{ref\_crystal} = 1/F_{ref\_ext} = 1/F_{ref\_1:1}$ , and  $\tau = 1.57x10^{-6}$  2(MFD +
- <sup>10</sup> PLL is operating in 1:1 PLL mode.
- <sup>11</sup> Jitter is the average deviation from the programmed frequency measured over the specified interval at maximum f<sub>sys/2</sub>. Measurements are made with the device powered by filtered supplies and clocked by a stable external clock signal. Noise injected into the PLL circuitry via V<sub>DDSYN</sub> and V<sub>SSSYN</sub> and variation in crystal oscillator frequency increase the Cjitter percentage for a given interval.
- <sup>12</sup> Values are with frequency modulation disabled. If frequency modulation is enabled, jitter is the sum of Cjitter+Cmod.
- $^{13}$  Modulation percentage applies over an interval of  $10\mu s$ , or equivalently the modulation rate is 100 KHz.
- Modulation rate selected must not result in  $f_{svs/2}$  value greater than the  $f_{svs/2}$  maximum specified value. Modulation range determined by hardware design. <sup>15</sup>  $f_{sys/2} = f_{ico} / (2 * 2^{RFD})$



# 7.5 External Interface Timing Characteristics

Table 11 lists processor bus input timings.

#### **NOTE**

All processor bus timings are synchronous; that is, input setup/hold and output delay with respect to the rising edge of a reference clock. The reference clock is the CLKOUT output.

All other timing relationships can be derived from these values.

**Table 11. Processor Bus Input Timing Specifications** 

Name	Characteristic <sup>1</sup>	Symbol	Min	Max	Unit				
freq	System bus frequency	f <sub>sys/2</sub>	50	75	MHz				
В0	CLKOUT period	t <sub>cyc</sub>	_	1/75	ns				
	Control Inputs								
B1a	Control input valid to CLKOUT high <sup>2</sup>	t <sub>CVCH</sub>	9	_	ns				
B1b	BKPT valid to CLKOUT high <sup>3</sup>	t <sub>BKVCH</sub>	9	_	ns				
B2a	CLKOUT high to control inputs invalid <sup>2</sup>	t <sub>CHCII</sub>	0	_	ns				
B2b	CLKOUT high to asynchronous control input BKPT invalid <sup>3</sup>	t <sub>BKNCH</sub>	0	_	ns				
	Data Inputs								
B4	Data input (D[31:0]) valid to CLKOUT high	t <sub>DIVCH</sub>	4	_	ns				
B5	CLKOUT high to data input (D[31:0]) invalid	t <sub>CHDII</sub>	0	_	ns				

Timing specifications are tested using full drive strength pad configurations in a 50ohm transmission line environment..

<sup>&</sup>lt;sup>2</sup> TEA and TA pins are being referred to as control inputs.

<sup>&</sup>lt;sup>3</sup> Refer to figure A-19.



Timings listed in Table 11 are shown in Figure 7.

\* The timings are also valid for inputs sampled on the negative clock edge.

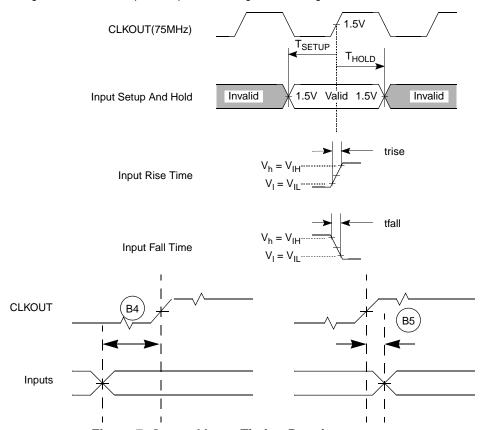


Figure 7. General Input Timing Requirements

# 7.6 Processor Bus Output Timing Specifications

Table 12 lists processor bus output timings.

**Table 12. External Bus Output Timing Specifications** 

Name	Characteristic		Min	Max	Unit				
	Control Outputs								
В6а	CLKOUT high to chip selects valid <sup>1</sup>	t <sub>CHCV</sub>	_	0.5t <sub>CYC</sub> +5	ns				
B6b	CLKOUT high to byte enables (BS[3:0]) valid <sup>2</sup>	t <sub>CHBV</sub>	_	0.5t <sub>CYC</sub> +5	ns				
B6c	CLKOUT high to output enable (OE) valid <sup>3</sup>	t <sub>CHOV</sub>	_	0.5t <sub>CYC</sub> +5	ns				
В7	CLKOUT high to control output (BS[3:0], OE) invalid	t <sub>CHCOI</sub>	0.5t <sub>CYC</sub> +1.5	_	ns				
В7а	CLKOUT high to chip selects invalid	t <sub>CHCI</sub>	0.5t <sub>CYC</sub> +1.5	_	ns				



**Table 12. External Bus Output Timing Specifications (continued)** 

Name	Characteristic	Symbol	Min	Max	Unit			
	Address and Attribute Outputs							
В8	CLKOUT high to address (A[23:0]) and control (TS, TSIZ[1:0], TIP, R/W) valid	t <sub>CHAV</sub>	_	9	ns			
В9	CLKOUT high to address (A[23:0]) and control (TS, TSIZ[1:0], TIP, R/W) invalid	t <sub>CHAI</sub>	1.5	_	ns			
	Data Outputs							
B11	CLKOUT high to data output (D[31:0]) valid	t <sub>CHDOV</sub>	_	9	ns			
B12	CLKOUT high to data output (D[31:0]) invalid	t <sub>CHDOI</sub>	1.5	_	ns			
B13	CLKOUT high to data output (D[31:0]) high impedance	t <sub>CHDOZ</sub>	_	9	ns			

CS transitions after the falling edge of CLKOUT.

BS transitions after the falling edge of CLKOUT.

OE transitions after the falling edge of CLKOUT.



Read/write bus timings listed in Table 12 are shown in Figure 8, Figure 9, and Figure 10.

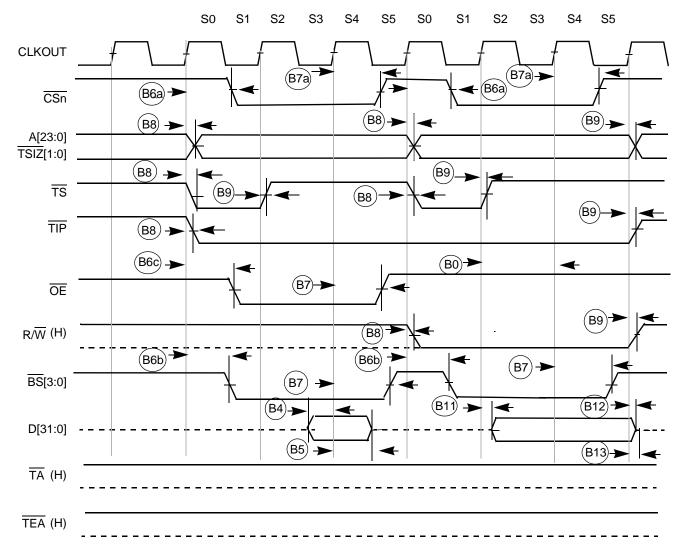


Figure 8. Read/Write (Internally Terminated) SRAM Bus Timing



Figure 9 shows a bus cycle terminated by  $\overline{TA}$  showing timings listed in Table 12.

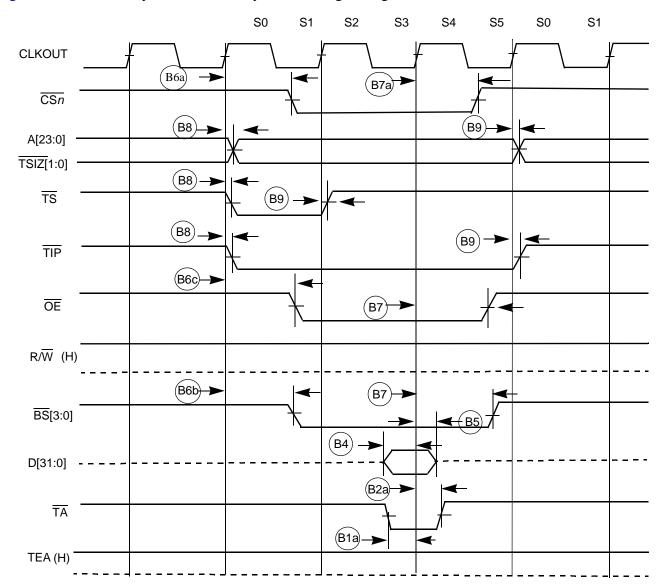


Figure 9. SRAM Read Bus Cycle Terminated by TA



Figure 10 shows an SRAM bus cycle terminated by TEA showing timings listed in Table 12.

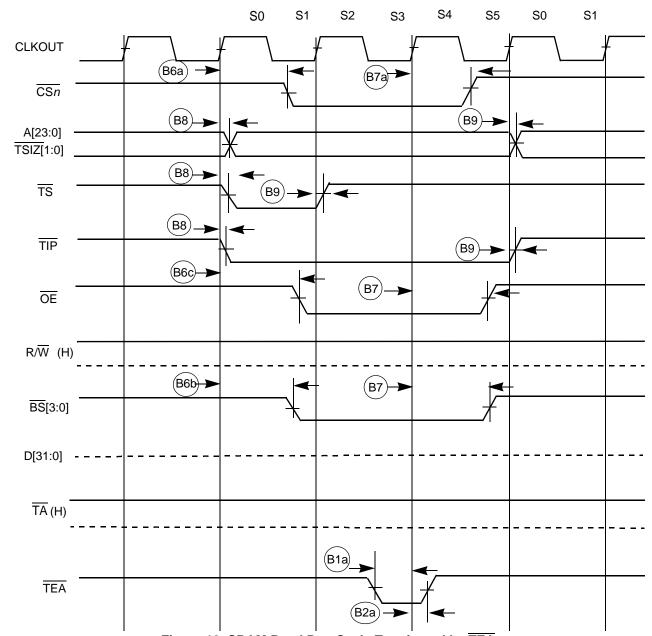


Figure 10. SRAM Read Bus Cycle Terminated by TEA



Figure 11 shows an SDRAM read cycle.

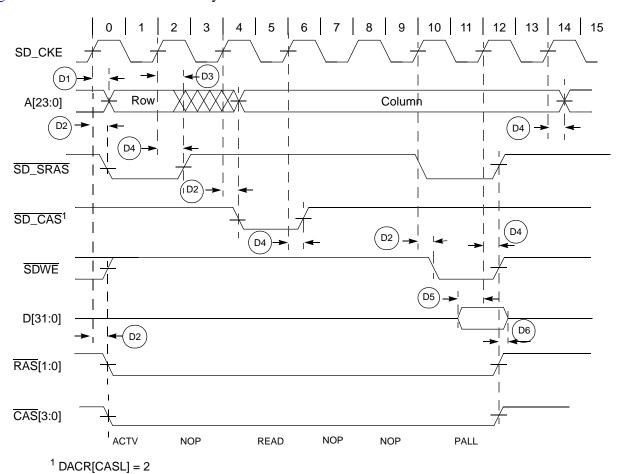


Figure 11. SDRAM Read Cycle

**Table 13. SDRAM Timing** 

NUM	Characteristic	Symbol	Min	Max	Unit
D1	CLKOUT high to SDRAM address valid	t <sub>CHDAV</sub>	_	9	ns
D2	CLKOUT high to SDRAM control valid	t <sub>CHDCV</sub>	_	9	ns
D3	CLKOUT high to SDRAM address invalid	t <sub>CHDAI</sub>	1.5	_	ns
D4	CLKOUT high to SDRAM control invalid	t <sub>CHDCI</sub>	1.5	_	ns
D5	SDRAM data valid to CLKOUT high	t <sub>DDVCH</sub>	4	_	ns
D6	CLKOUT high to SDRAM data invalid	t <sub>CHDDI</sub>	1.5	_	ns
D7 <sup>1</sup>	CLKOUT high to SDRAM data valid	t <sub>CHDDVW</sub>	_	9	ns
D8 <sup>1</sup>	CLKOUT high to SDRAM data invalid	t <sub>CHDDIW</sub>	1.5	_	ns

<sup>&</sup>lt;sup>1</sup> D7 and D8 are for write cycles only.



Figure 12 shows an SDRAM write cycle.

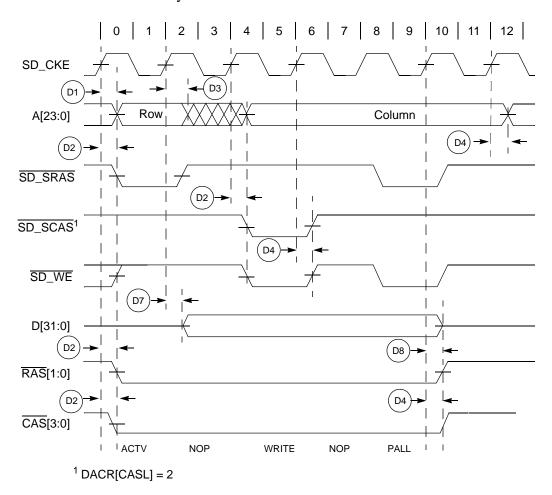


Figure 12. SDRAM Write Cycle

#### **General Purpose I/O Timing** 7.7

Table 14. GPIO Timing<sup>1</sup>

NUM	Characteristic	Symbol	Min	Max	Unit
G1	CLKOUT High to GPIO Output Valid	t <sub>CHPOV</sub>	_	10	ns
G2	CLKOUT High to GPIO Output Invalid	t <sub>CHPOI</sub>	1.5	_	ns
G3	GPIO Input Valid to CLKOUT High	t <sub>PVCH</sub>	9	_	ns
G4	CLKOUT High to GPIO Input Invalid	t <sub>CHPI</sub>	1.5	_	ns

<sup>&</sup>lt;sup>1</sup> GPIO pins include: INT, UART, Timer,  $\overline{DREQn}$  and  $\overline{DACKn}$  pins.

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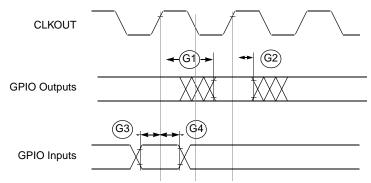


Figure 13. GPIO Timing

# 7.8 Reset and Configuration Override Timing

Table 15. Reset and Configuration Override Timing  $(V_{DD} = 2.7 \text{ to } 3.6 \text{ V}, V_{SS} = 0 \text{ V}, T_A = T_L \text{ to } T_H)^1$ 

NUM	Characteristic	Symbol	Min	Max	Unit
R1	RESET Input valid to CLKOUT High	t <sub>RVCH</sub>	9	_	ns
R2	CLKOUT High to RESET Input invalid	t <sub>CHRI</sub>	1.5	_	ns
R3	RESET Input valid Time <sup>2</sup>	t <sub>RIVT</sub>	5		t <sub>CYC</sub>
R4	CLKOUT High to RSTOUT Valid	t <sub>CHROV</sub>	_	10	ns
R5	RSTOUT valid to Config. Overrides valid	t <sub>ROVCV</sub>	0	_	ns
R6	Configuration Override Setup Time to RSTOUT invalid	t <sub>cos</sub>	20	_	t <sub>CYC</sub>
R7	Configuration Override Hold Time after RSTOUT invalid	t <sub>COH</sub>	0	_	ns
R8	RSTOUT invalid to Configuration Override High Impedance	t <sub>ROICZ</sub>	_	1	t <sub>CYC</sub>

All AC timing is shown with respect to 50%  $V_{DD}$  levels unless otherwise noted.

During low power STOP, the synchronizers for the RESET input are bypassed and RESET is asserted asynchronously to the system. Thus, RESET must be held a minimum of 100 ns.

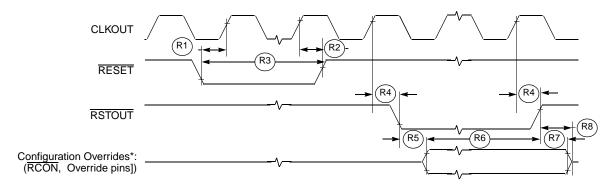


Figure 14. RESET and Configuration Override Timing

Refer to the chip configuration module (CCM) chapter in the device's reference manual for more information.



# 7.9 I<sup>2</sup>C Input/Output Timing Specifications

Table 16 lists specifications for the I<sup>2</sup>C input timing parameters shown in Figure 15.

Table 16. I<sup>2</sup>C Input Timing Specifications between I2C\_SCL and I2C\_SDA

Num	Characteristic	Min	Max	Units
I1	Start condition hold time	2	_	t <sub>cyc</sub>
12	Clock low period	8	_	t <sub>cyc</sub>
13	I2C_SCL/I2C_SDA rise time ( $V_{IL} = 0.5 \text{ V to } V_{IH} = 2.4 \text{ V}$ )	_	1	ms
14	Data hold time	0	_	ns
15	I2C_SCL/I2C_SDA fall time ( $V_{IH} = 2.4 \text{ V to } V_{IL} = 0.5 \text{ V}$ )	_	1	ms
16	Clock high time	4	_	t <sub>cyc</sub>
17	Data setup time	0	_	ns
18	Start condition setup time (for repeated start condition only)	2	_	t <sub>cyc</sub>
19	Stop condition setup time	2	_	t <sub>cyc</sub>

Table 17 lists specifications for the I<sup>2</sup>C output timing parameters shown in Figure 15.

Table 17. I<sup>2</sup>C Output Timing Specifications between I2C\_SCL and I2C\_SDA

Num	Characteristic	Min	Max	Units
I1 <sup>1</sup>	Start condition hold time	6	_	t <sub>cyc</sub>
I2 <sup>1</sup>	Clock low period	10	_	t <sub>cyc</sub>
I3 <sup>2</sup>	I2C_SCL/I2C_SDA rise time ( $V_{IL} = 0.5 \text{ V to } V_{IH} = 2.4 \text{ V}$ )	_	_	μs
I4 <sup>1</sup>	Data hold time	7	_	t <sub>cyc</sub>
I5 <sup>3</sup>	I2C_SCL/I2C_SDA fall time ( $V_{IH} = 2.4 \text{ V to } V_{IL} = 0.5 \text{ V}$ )	_	3	ns
I6 <sup>1</sup>	Clock high time	10	_	t <sub>cyc</sub>
I7 <sup>1</sup>	Data setup time	2	_	t <sub>cyc</sub>
I8 <sup>1</sup>	Start condition setup time (for repeated start condition only)	20	_	t <sub>cyc</sub>
I9 <sup>1</sup>	Stop condition setup time	10	_	t <sub>cyc</sub>

Note: Output numbers depend on the value programmed into the IFDR; an IFDR programmed with the maximum frequency (IFDR = 0x20) results in minimum output timings as shown in Table 17. The I<sup>2</sup>C interface is designed to scale the actual data transition time to move it to the middle of the I2C\_SCL low period. The actual position is affected by the prescale and division values programmed into the IFDR; however, the numbers given in Table 17 are minimum values.

Figure 15 shows timing for the values in Table 16 and Table 17.

Because I2C\_SCL and I2C\_SDA are open-collector-type outputs, which the processor can only actively drive low, the time I2C\_SCL or I2C\_SDA take to reach a high level depends on external signal capacitance and pull-up resistor values.

<sup>&</sup>lt;sup>3</sup> Specified at a nominal 50-pF load.



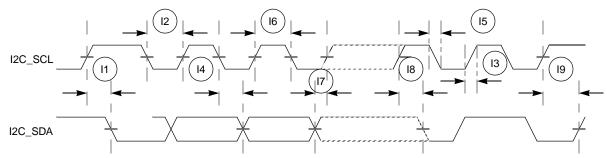


Figure 15. I<sup>2</sup>C Input/Output Timings

# 7.10 Fast Ethernet AC Timing Specifications

MII signals use TTL signal levels compatible with devices operating at either 5.0 V or 3.3 V.

# 7.10.1 MII Receive Signal Timing (ERXD[3:0], ERXDV, ERXER, and ERXCLK)

The receiver functions correctly up to a ERXCLK maximum frequency of 25 MHz +1%. The processor clock frequency must exceed twice the ERXCLK frequency.

Table 18 lists MII receive channel timings.

**Table 18. MII Receive Signal Timing** 

Num	Characteristic	Min	Max	Unit
M1	ERXD[3:0], ERXDV, ERXER to ERXCLK setup	5	_	ns
M2	ERXCLK to ERXD[3:0], ERXDV, ERXER hold	5	_	ns
М3	ERXCLK pulse width high	35%	65%	ERXCLK period
M4	ERXCLK pulse width low	35%	65%	ERXCLK period

Figure 16 shows MII receive signal timings listed in Table 18.

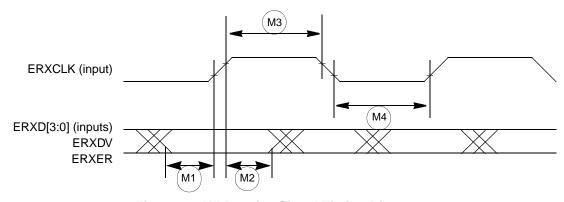


Figure 16. MII Receive Signal Timing Diagram



# 7.10.2 MII Transmit Signal Timing (ETXD[3:0], ETXEN, ETXER, ETXCLK)

Table 19 lists MII transmit channel timings.

The transmitter functions correctly up to a ETXCLK maximum frequency of 25 MHz +1%. The processor clock frequency must exceed twice the ETXCLK frequency.

Num Characteristic Min Max Unit ETXCLK to ETXD[3:0], ETXEN, ETXER invalid M5 5 ns ETXCLK to ETXD[3:0], ETXEN, ETXER valid M6 25 ETXCLK pulse width high ETXCLK period M7 35% 65% M8 ETXCLK pulse width low 65% ETXCLK period 35%

**Table 19. MII Transmit Signal Timing** 

Figure 17 shows MII transmit signal timings listed in Table 19.

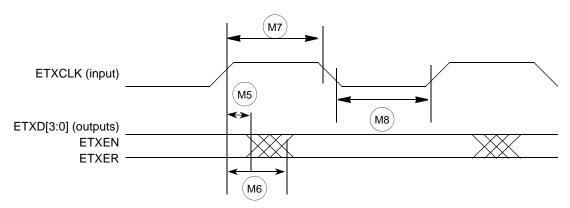


Figure 17. MII Transmit Signal Timing Diagram

# 7.10.3 MII Async Inputs Signal Timing (ECRS and ECOL)

Table 20 lists MII asynchronous inputs signal timing.

**Table 20. MII Async Inputs Signal Timing** 

Num	Characteristic	Min	Max	Unit
M9	ECRS, ECOL minimum pulse width	1.5		ETXCLK period

Figure 18 shows MII asynchronous input timings listed in Table 20.



Figure 18. MII Async Inputs Timing Diagram



## 7.10.4 MII Serial Management Channel Timing (EMDIO and EMDC)

Table 21 lists MII serial management channel timings. The FEC functions correctly with a maximum MDC frequency of 2.5 MHz.

**Table 21. MII Serial Management Channel Timing** 

Num	Characteristic	Min	Max	Unit
M10	EMDC falling edge to EMDIO output invalid (minimum propagation delay)	0	_	ns
M11	EMDC falling edge to EMDIO output valid (max prop delay)	_	25	ns
M12	EMDIO (input) to EMDC rising edge setup	10	_	ns
M13	EMDIO (input) to EMDC rising edge hold	0	_	ns
M14	EMDC pulse width high	40%	60%	MDC period
M15	EMDC pulse width low	40%	60%	MDC period

Figure 19 shows MII serial management channel timings listed in Table 21.

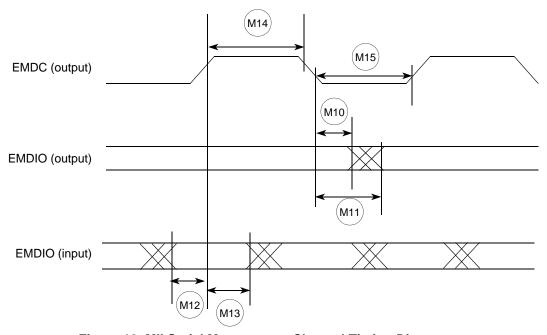


Figure 19. MII Serial Management Channel Timing Diagram



# 7.11 32-Bit Timer Module AC Timing Specifications

Table 22 lists timer module AC timings.

**Table 22. Timer Module AC Timing Specifications** 

Name	Characteristic	0–66	66 MHz	Unit
Name	Gharacteristic	Min	Max	Oilit
T1	DT0IN / DT1IN / DT2IN / DT3IN cycle time	3	_	t <sub>CYC</sub>
T2	DT0IN / DT1IN / DT2IN / DT3IN pulse width	1	_	t <sub>CYC</sub>

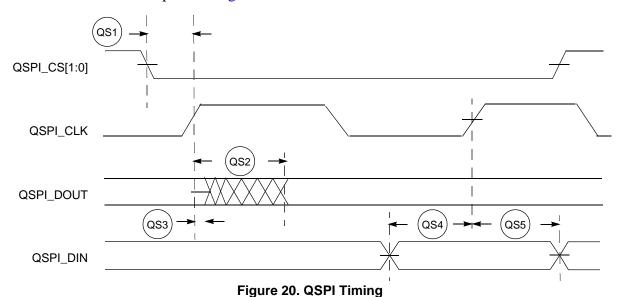
# 7.12 QSPI Electrical Specifications

Table 23 lists QSPI timings.

**Table 23. QSPI Modules AC Timing Specifications** 

Name	Characteristic	Min	Max	Unit
QS1	QSPI_CS[1:0] to QSPI_CLK	1	510	tcyc
QS2	QSPI_CLK high to QSPI_DOUT valid.	_	10	ns
QS3	QSPI_CLK high to QSPI_DOUT invalid. (Output hold)	2	_	ns
QS4	QSPI_DIN to QSPI_CLK (Input setup)	9	_	ns
QS5	QSPI_DIN to QSPI_CLK (Input hold)	9	_	ns

The values in Table 23 correspond to Figure 20.





# 7.13 JTAG and Boundary Scan Timing

Table 24. JTAG and Boundary Scan Timing

Num	Characteristics <sup>1</sup>	Symbol	Min	Max	Unit
J1	TCLK Frequency of Operation	f <sub>JCYC</sub>	DC	1/4	f <sub>sys/2</sub>
J2	TCLK Cycle Period	t <sub>JCYC</sub>	4	_	t <sub>CYC</sub>
J3	TCLK Clock Pulse Width	t <sub>JCW</sub>	26	_	ns
J4	TCLK Rise and Fall Times	t <sub>JCRF</sub>	0	3	ns
J5	Boundary Scan Input Data Setup Time to TCLK Rise	t <sub>BSDST</sub>	4	_	ns
J6	Boundary Scan Input Data Hold Time after TCLK Rise	t <sub>BSDHT</sub>	26	_	ns
J7	TCLK Low to Boundary Scan Output Data Valid	t <sub>BSDV</sub>	0	33	ns
J8	TCLK Low to Boundary Scan Output High Z	t <sub>BSDZ</sub>	0	33	ns
J9	TMS, TDI Input Data Setup Time to TCLK Rise	t <sub>TAPBST</sub>	4	_	ns
J10	TMS, TDI Input Data Hold Time after TCLK Rise	t <sub>TAPBHT</sub>	10	_	ns
J11	TCLK Low to TDO Data Valid	t <sub>TDODV</sub>	0	26	ns
J12	TCLK Low to TDO High Z	t <sub>TDODZ</sub>	0	8	ns
J13	TRST Assert Time	t <sub>TRSTAT</sub>	100	_	ns
J14	TRST Setup Time (Negation) to TCLK High	t <sub>TRSTST</sub>	10	_	ns

JTAG\_EN is expected to be a static signal. Hence, specific timing is not associated with it.

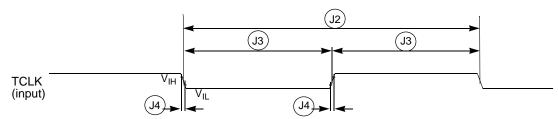


Figure 21. Test Clock Input Timing



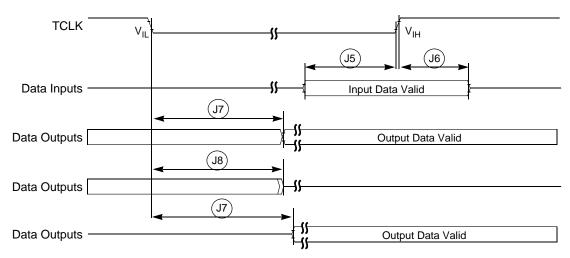


Figure 22. Boundary Scan (JTAG) Timing

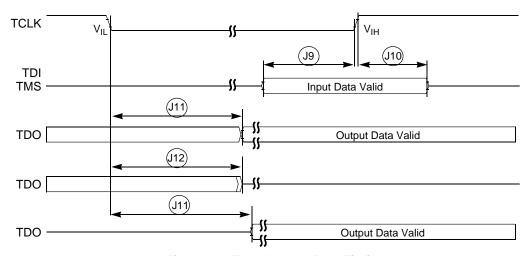
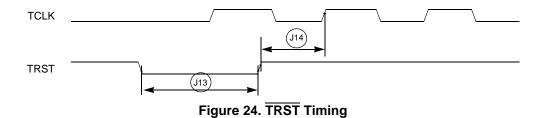


Figure 23. Test Access Port Timing





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**Electrical Characteristics** 

# 7.14 Debug AC Timing Specifications

Table 25 lists specifications for the debug AC timing parameters shown in Figure 26.

**Table 25. Debug AC Timing Specification** 

Num	Characteristic	150	MHz	Units
Nulli	Characteristic	Min	Max	Oillis
DE0	PSTCLK cycle time	_	0.5	t <sub>cyc</sub>
DE1	PST valid to PSTCLK high	4		ns
DE2	PSTCLK high to PST invalid	1.5	_	ns
DE3	DSCLK cycle time	5	_	t <sub>cyc</sub>
DE4	DSI valid to DSCLK high	1	_	t <sub>cyc</sub>
DE5 <sup>1</sup>	DSCLK high to DSO invalid	4	_	t <sub>cyc</sub>
DE6	BKPT input data setup time to CLKOUT rise	4	_	ns
DE7	CLKOUT high to BKPT high Z	0	10	ns

DSCLK and DSI are synchronized internally. D4 is measured from the synchronized DSCLK input relative to the rising edge of CLKOUT.

Figure 25 shows real-time trace timing for the values in Table 25.

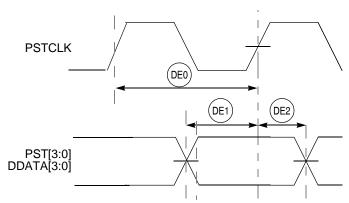


Figure 25. Real-Time Trace AC Timing

Figure 26 shows BDM serial port AC timing for the values in Table 25.

MCF5271 Integrated Microprocessor Hardware Specification, Rev. 4



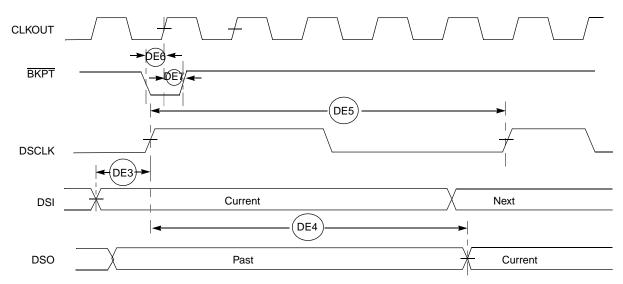


Figure 26. BDM Serial Port AC Timing

# 8 Documentation

Documentation regarding the MCF5271 and their development support tools is available from a local Freescale distributor, a Freescale semiconductor sales office, the Freescale Literature Distribution Center, or through the Freescale web address at <a href="http://www.freescale.com/coldfire">http://www.freescale.com/coldfire</a>.

# 9 Document Revision History

The below table provides a revision history for this document.

Table 26. MCF5271EC Revision History

Rev. No.	Substantive Change(s)
0	Initial release
1	Fixed several clock values.     Updated Signal List table
1.1	Removed duplicate information in the module description sections. The information is all in the Signals Description Table.
1.2	<ul> <li>Removed detailed signal description section. This information can be found in the MCF5271RM Chapter 2.</li> <li>Removed detailed feature list. This information can be found in the MCF5271RM Chapter 1.</li> <li>Changed instances of Motorola to Freescale</li> <li>Added values for 'Maximum operating junction temperature' in Table 8.</li> <li>Added typical values for 'Core operating supply current (master mode)' in Table 9.</li> <li>Added typical values for 'Pad operating supply current (master mode)' in Table 9.</li> <li>Removed unnecessary PLL specifications, #6-9, in Table 10.</li> </ul>



#### **Document Revision History**

## Table 26. MCF5271EC Revision History (continued)

Rev. No.	Substantive Change(s)
1.3	<ul> <li>Device is now available in 150 MHz versions. Updated specs where necessary to reflect this improvement.</li> <li>Added 2 new part numbers to Table 6: MCF5270CVM150 and MCF5271CVM150.</li> <li>Removed features list. This information can be found in the MCF5271RM.</li> <li>Removed SDRAM address multiplexing section. This information can be found in the MCF5271RM.</li> </ul>
1.4	<ul> <li>Added Section 5.2.1, "Supply Voltage Sequencing and Separation Cautions."</li> <li>Updated 196MAPBGA package dimensions, Figure 4.</li> </ul>
2	<ul> <li>Table 2: Changed SD_CKE pin location from 139 to "—" for the 160QFP device.</li> <li>Table 2: Changed QSPI_CS1 pin location from "—" to 139 for the 160QFP device.</li> <li>Table 2: Changed DT3IN pin's alternate 2 function from "—" to QSPI_CS2.</li> <li>Table 2: Changed DT3OUT pin's alternate 2 function from "—" to QSPI_CS3.</li> <li>Figure 5: Changed pin 139 label from "SD_CKE/QSPI_CS1" to "QSPI_CS1/SD_CKE".</li> <li>Removed second sentence from Section 7.10.1, "MII Receive Signal Timing (ERXD[3:0], ERXDV, ERXER, and ERXCLK)," and Section 7.10.2, "MII Transmit Signal Timing (ETXD[3:0], ETXEN, ETXER, ETXCLK)," regarding no minimum frequency requirement for TXCLK.</li> <li>Removed third and fourth paragraphs from Section 7.10.2, "MII Transmit Signal Timing (ETXD[3:0], ETXEN, ETXER, ETXCLK)," as this feature is not supported on this device.</li> </ul>
3	<ul> <li>Section 5.2.1, "Supply Voltage Sequencing and Separation Cautions" changed PLLV<sub>DD</sub> to V<sub>DDPLL</sub> to match rest of document.</li> <li>Section 5.2.1, "Supply Voltage Sequencing and Separation Cautions" Changed V<sub>DDPLL</sub> voltage level from 1.5V to 3.3V throughout section.</li> <li>Section 5.2.1.1, "Power Up Sequence" first bullet, changed "Use 1 μs" to "Use 1 ms".</li> <li>Corrected position of spec D5 in Figure 11.</li> <li>Figure 3: Corrected M4 ball location from DATA5 to DATA6, changed DATA<i>n</i> labels to D<i>n</i> for consistency</li> <li>Table 14: Added DACK<i>n</i> and DREQ<i>n</i> to footnote.</li> <li>Table 9, added PLL supply voltage row</li> </ul>
4	Added part number MCF5270CAB100 in Table 6







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